

Product Summary

V _{(BR)DSS}	R _{DS(on)TYP}	l _D
60V	25mΩ@10V	20A
00 V	32mΩ@4.5V	20A
60)/	57mΩ@-10V	101
-60V	70mΩ@-4.5V	-18A



Feature

- High power and current handing capability
- Lead free product is acquired
- Surface mount package
- 100% Single Pluse avalanche energy Test

Applications

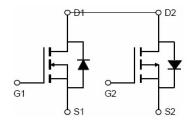
- Battery Protection
- Load Switch
- Power Management

Package

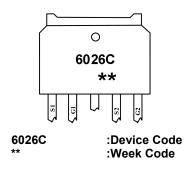


TO-252-4L

Circuit diagram



Marking



Order Information

Device	Package	Unit/Tape		
SP6026CTM	TO-252-4L	2500		



Absolute maximum ratings (Ta=25°C,unless otherwise noted)

Parameter	Cymphol	Va	l luite		
Parameter	Symbol	N-Channel	P-Channel	Units	
Drain-Source Voltage	V _{DS}	60	-60	V	
Gate-Source Voltage	V _G S	±20	±20	V	
Continuous Drain Current (T _C =25°ℂ)	I _D	20	-18	А	
Continuous Drain Current (T _C =100°C)	I _D	13	-12	А	
Pulsed Drain Current	I _{DM}	80	-72	А	
Single Pulse Avalanche Energy ¹	E _{AS}	29	48	mJ	
Power Dissipation (T _C =25°ℂ)	P _D	40		W	
Thermal Resistance Junction-to-Case	Rejc	3.1		°C/W	
Storage Temperature Range	T _{STG}	-55 to 150		$^{\circ}$	
Operating Junction Temperature Range	TJ	-55 to 150		${\mathbb C}$	

N-Channel Electrical characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Static Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V , ID=250uA	60	-	-	V	
Drain-Source Leakage Current	I _{DSS}	VDS=48V , VGS=0V , TJ=25℃	-	-	1	uA	
Gate-Source Leakage Current	I _{GSS}	VGS=±20V, VDS=0V	-	-	±100	nA	
Gate Threshold Voltage	V _{GS(th)}	VGS=VDS , ID =250uA		1.6	2.5	V	
01 11 12 13 13 13 13 13 13 13 13 13 13 13 13 13		VGS=10V , ID=10A	-	25	35	mo	
Static Drain-Source On-Resistance	R _{DS(ON)}	VGS=4.5V , ID=8A	-	32	46	mΩ	
Dynamic characteristics							
Input Capacitance	C _{iss}		-	1165	-		
Output Capacitance	Coss	VDS=25V , VGS=0V , f=1MHz	-	53	-	pF	
Reverse Transfer Capacitance	C _{rss}			46	-		
Total Gate Charge	Qg	VDS=30V , VGS=10V , ID=10A		20	_		
Gate-Source Charge	Q _{gs}			4	-	nC	
Gate-Drain Charge	Q_{gd}			5	-		
Switching Characteristics							
Turn-On Delay Time	T _{d(on)}			7.5	-		
Rise Time	Tr	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	-	20	-	nS	
Turn-Off Delay Time	T _{d(off)}	VDD=30V, VGS=10V , RG=3Ω, ID=10A		16	-	113	
Fall Time	T _f			25	-		
Diode Characteristics							
Diode Forward Voltage	V _{SD}	VGS=0V , IS=1A , TJ=25℃	-	-	1.2	V	
Maximum Body-Diode Continuous Current	Is		-	-	20	Α	
Reverse Recovery Time	Trr	I _S =20A, di/dt=100A/us, TJ=25℃		35	-	nS	
Reverse Recovery Charge	Qrr			53	-	nC	

Note:

^{1.}The EAS test condition is VDD=30V,VGS=10V,L=0.1mH,RG=25 Ω



P-Channel Electrical characteristics (Ta=25℃, unless otherwise noted)

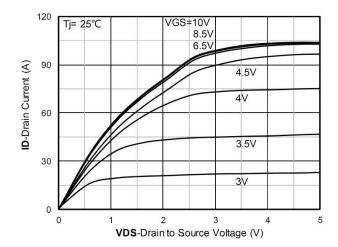
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	
Static Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V , ID=-250uA	-60	_	-	V	
Drain-Source Leakage Current	I _{DSS}	VDS=-48V , VGS=0V , TJ=25℃	-	-	-1	uA	
Gate-Source Leakage Current	I _{GSS}	VGS=±20V , VDS=0V	-	-	±100	nA	
Gate Threshold Voltage	V _{GS(th)}	VGS=VDS , ID =-250uA	-1	-1.5	-2.5	V	
		VGS=-10V , ID=-2A	-	57	71		
Static Drain-Source On-Resistance	R _{DS(ON)}	VGS=-4.5V , ID=-1A	-	70	93	mΩ	
Dynamic characteristics							
Input Capacitance	C _{iss}		-	1090	-		
Output Capacitance	Coss	VDS=-30V , VGS=0V , f=1MHz	-	77	-	pF	
Reverse Transfer Capacitance	C _{rss}	1		58	-		
Total Gate Charge	Qg	VDS=-30V , VGS=-10V , ID=-6A		23	-		
Gate-Source Charge	Q _{gs}			4.2	-	nC	
Gate-Drain Charge	Q _{gd}			4.8	-		
Switching Characteristics							
Turn-On Delay Time	T _{d(on)}			9.8	-		
Rise Time	Tr	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	-	6.1	-	nS	
Turn-Off Delay Time	T _{d(off)}	VDD=-30V, VGS=-10V ,RG=3Ω,ID=-10A		44	-	113	
Fall Time	T _f			12.7	-		
Diode Characteristics							
Diode Forward Voltage	V _{SD}	VGS=0V , IS=-1A , TJ=25℃	-	-	-1.2	V	
Maximum Body-Diode Continuous Current	Is		-	-	-18	Α	
Reverse Recovery Time	T _{rr}	L = 9A di/dt=100A/up T1=25°C	-	25	-	nS	
Reverse Recovery Charge	Q _{rr}	l _s =-8A, di/dt=100A/us, TJ=25℃		31	-	nC	

Note:

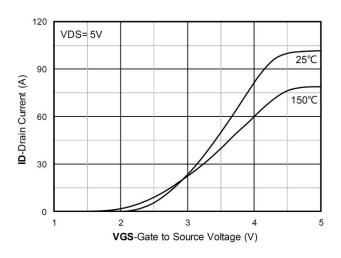
^{1.}The EAS test condition is VDD=-30V,VGS=-10V,L=0.1mH,RG=25 Ω



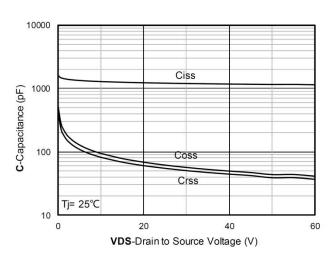
N-Channel Typical Characteristics



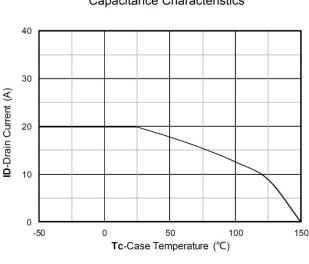
Output Characteristics



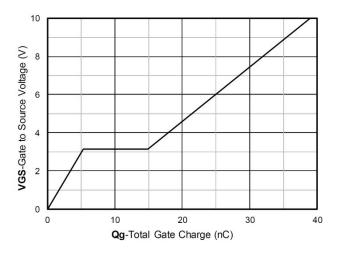
Transfer Characteristics



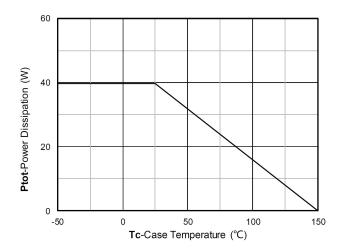
Capacitance Characteristics



Current dissipation

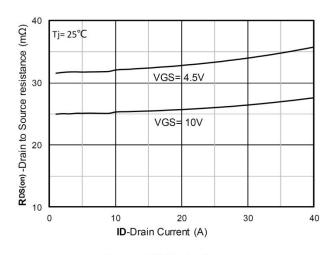


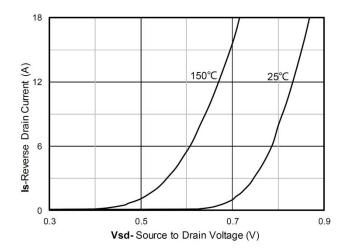
Gate Charge



Power dissipation

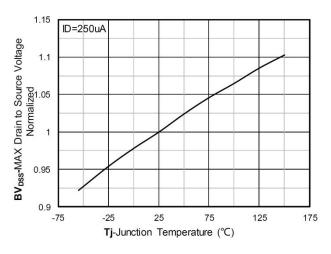


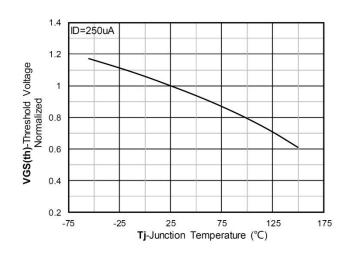




RDS(on) VS Drain Current

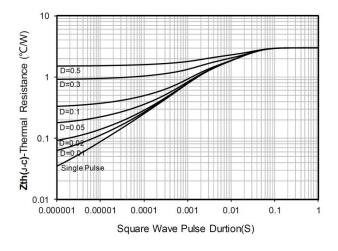
Forward characteristics of reverse diode

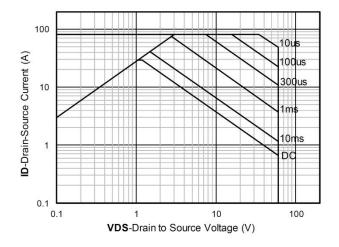




Normalized breakdown voltage

Normalized Threshold voltage



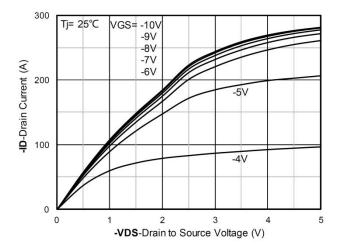


Maximum Transient Thermal Impedance

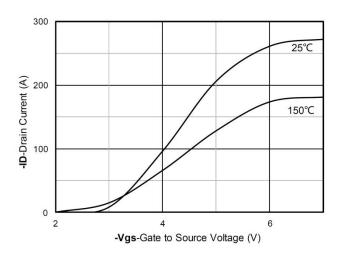
Safe Operation Area



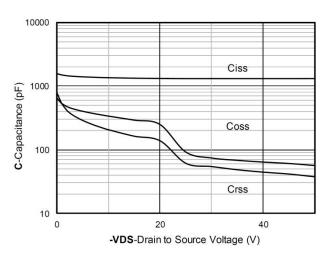
P-Channel Typical Characteristics



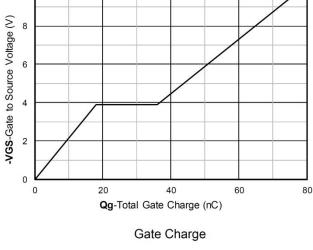
Output Characteristics



Transfer Characteristics

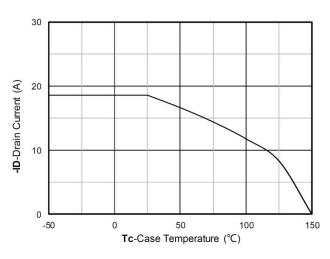


Capacitance Characteristics



60 Vote Dissipation (N) 40 Vot

10

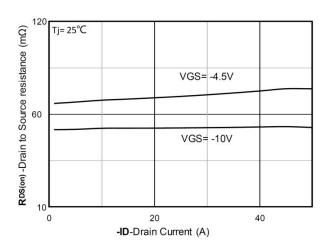


Current dissipation

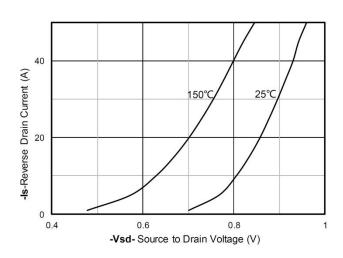
Power dissipation

150

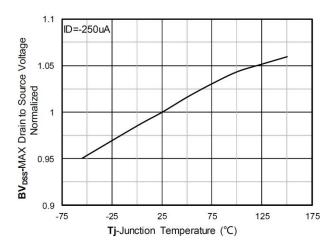




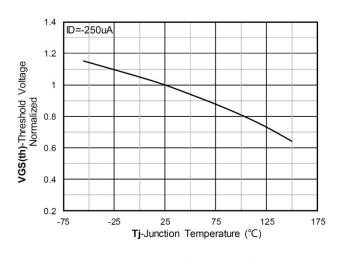
RDS(on) VS Drain Current



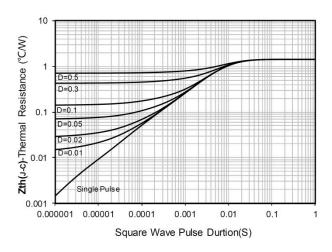
Forward characteristics of reverse diode



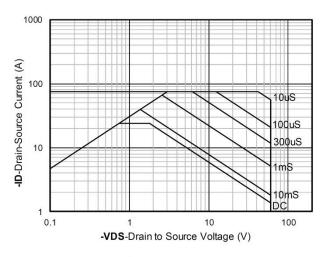
Normalized breakdown voltage



Normalized Threshold voltage



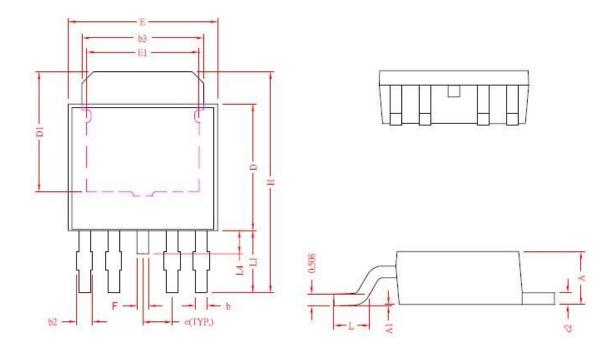
Maximum Transient Thermal Impedance



Safe Operation Area



TO-252-4L Package Information



Symbol	Dimensions In Millimeters			
	Min.	Max.		
A	2.20	2.40		
A1	0	0.15		
b	0.40	0.60		
b2	0.50	0.80		
b3	5.20	5.50		
c2	0.45	0.55		
D	5.40	5.80		
D1	4.57	-		
E	6.40	6.80		
E1	3.81	-		
е	1.27REF.			
F	0.40	0.60		
Н	9.40	10.20		
L	1.40	1.77		
L1	2.40	3.00		
L4	0.80	1.20		